IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:							
Je-Hyoung RYU, et al.							
Application No.:				Group Art Unit:			
Filed: Ap	oril 14	l, 200	4	Examiner:			
For: IN	ISPE	CTIN	G APPARATUS FOR SEMICON	NDUCTOR DEVICE			
			INFORMATION DISCLOS	SURE STATEMENT			
Commiss PO Box 1 Alexandr	1450						
Sir:							
In accordance with the duty of disclosure provisions of 37 CFR § 1.56, there is hereby provided certain information which the Examiner may consider material to the examination of the subject U.S. patent application. It is requested that the Examiner make this information of record if it is deemed material to the examination of the subject application.							
1. Enclosure		Encl	osures accompanying this Inforr	mation Disclosure Statement are:			
	1a. 1b. 1c. 1d.		application or a PCT Internation English language translation (c each non-English language pul Explanations of Relevancy of F	earch report(s) from a counterpart foreign nal Search Report. omplete or relevant portion(s)) attached to			
2. In accordance with 37 CFR § 1.98, a concise explanation of what is presently understood to be the relevance of each non-English language publication is							
	2a.		enclosed "English-language ve indicates the degree of relevan 609, Minimum Requirements for A(3): Concise Explanation of R Feb. 2000.)	s 2a, 2b, 2c and/or 2d) sh language publications were cited on the rsion of the search report or action which ce found by the foreign office". (See MPEP or an Information Disclosure Statement, Part elevance, pp. 600-100 to 600-101, Rev. 1,			
	2b.	\boxtimes	set forth in the application.				

	2c. 2d.			ach noi	uage translation (complete or relevant n-English language publication. eto.		
3.	3. No admission is made that the information cited in this Statement is, or is considere to be, material to patentability nor a representation that a search has been made (other than search report(s) from a counterpart foreign application or a PCT International Search Report, if submitted herewith). 37 CFR §§ 1.97(g) and (h).						
					Respectfully submitted,		
					STAAS & HALSEY LLP		
Dated:	v Yor on, E e: (20	1k Ανε D.C. 1 02) 4∶	34-1500	By	Gene M. Garner II Registration No. 34,172		

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO. 1572.1242

APPLICATION NO.

LIST OF REFERENCES CITED BY APPLICANT

Je-Hyoung RYU, et al.

(Use several sheets if necessary)

FILING DATE

April 14, 2004

FIRST NAMED INVENTOR

GROUP ART UNIT

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	АВ						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSI YES	ATION NO
AG	KR 2003-6195	1/23/03	Korea			Х	
АН		-					
AI							
AJ							
AK							
AL						-	

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

			TRANSL YES	
	АМ	Korean Utility Model #20-0157983		X
	AN			
	AO			

EXAMINER

DATE CONSIDERED

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

ATTACHMENT 1(e)

EXPLANATIONS OF RELEVANCY OF REFERENCES

	1550.0045.00
ATTORNEY DOCKET NO.	APPLICATION NO.
1572.1242	
FIRST NAMED INVENTOR	
Je-Hyoung RYU, et al.	
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FILING DATE	GROUP ART UNIT
A	
April 14, 2004	

Reference AG (KR 2003-6195) is entitled "Semiconductor Element Testing Apparatus".